







**CD74ACT14** 

SCHS319C - NOVEMBER 2002 - REVISED AUGUST 2024

# CD74ACT14 Hex Schmitt-Trigger Inverter

## **1** Features

Texas

Instruments

- Inputs are TTL-voltage compatible
- Speed of bipolar F, AS, and S, with significantly • reduced power consumption
- Greater noise immunity than standard inverters
- Operates with much slower than standard input rise and fall slew rates
- ±24mA output drive current - Fanout to 15 F devices
- SCR-latchup-resistant CMOS process and circuit • design

## 2 Description

The CD74ACT14 contains six independent inverters. This device performs the Boolean function  $Y = \overline{A}$ .

#### **Package Information**

PART NUMBER PACKAGE <sup>(1)</sup>		PACKAGE SIZE <sup>(2)</sup>	BODY SIZE <sup>(3)</sup>	
CD74ACT14	D (SOIC, 14)	8.65mm x 6mm	8.65mm × 3.9mm	
CD74ACT14	N (PDIP, 14)	19.3mm x 9.4mm	19.3mm × 6.35mm	

For more information, see Section 10. (1)

- (2) The package size (length × width) is a nominal value and includes pins, where applicable.
- The body size (length × width) is a nominal value and does (3) not include pins.

Г Υ

Logic Diagram (Positive Logic)





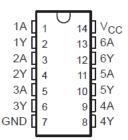
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## **3 Pin Configuration and Functions**



## Figure 3-1. CD74ACT14 D or N Package, 14-Pin SOIC or PDIP (Top View)

#### **Table 3-1. Pin Functions**

PIN		- I/O	DESCRIPTION				
NAME	NO.	I/O	DESCRIPTION				
1A	1	Input	Channel 1, Input A				
1Y	2	Output	Channel 1, Output Y				
2A	3	Input	Channel 2, Input A				
2Y	4	Output	Channel 2, Output Y				
3A	5	Input	Channel 3, Input A				
3Y	6	Output	Channel 3, Output Y				
GND	7		Ground				
4Y	8	Output	Channel 4, Output Y				
4A	9	Input	Channel 4, Input A				
5Y	10	Output	Channel 5, Output Y				
5A	11	Input	Channel 5, Input A				
6Y	12	Output	Channel 6, Output Y				
6A	13	Input	Channel 6, Input A				
V <sub>CC</sub>	14	_	Positive Supply				

## 4 Specifications

### 4.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage	-0.5	6	V	
I <sub>IK</sub> <sup>(2)</sup>	Input clamp current	$(V_{l} < 0 \text{ or } V_{l} > V_{CC})$		±20	mA
I <sub>OK</sub> <sup>(2)</sup>	Output clamp current	$(V_O < 0 \text{ or } V_O > V_{CC})$		±50	mA
I <sub>O</sub>	Continuous output current	$(V_{O} = 0 \text{ to } V_{CC})$		±50	mA
	Continuous current through V <sub>CC</sub> or GND	·		±100	mA
T <sub>stg</sub>	Storage temperature		-65	150	°C

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

#### 4.2 ESD Ratings

			VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	±2000	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

### 4.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		TA = 2	TA = 25°C		– 55°C to 125°C		– 40°C to 85°C	
		MIN	MAX	MIN	MAX	MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage	4.5	5.5	4.5	5.5	4.5	5.5	V
VI	Input voltage	0	V <sub>CC</sub>	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
Vo	Output voltage	0	V <sub>CC</sub>	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
I <sub>OH</sub>	High-level output current		-24		-24		-24	mA
I <sub>OL</sub>	Low-level output current		24		24		24	mA
T∆t/∆v	Input transition rise or fall rate		20		20		20	°C

#### 4.4 Thermal Information

	CD74/			
THERMAL METRIC	N (PDIP)	UNIT		
		14 PINS	14 PINS	
R <sub>0JA</sub> Junction-to-ambient thermal resistance		80	89.9	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

### 4.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	T <sub>A</sub> = 25°C		– 55°C TO 125°C		– 40°C TO 85°C		UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX	UNIT	
V <sub>T+</sub> Positive-going threshold		5 V	1.4	2	1.4	2	1.4	2	V	
V <sub>T</sub> _ Negative-going threshold		5 V	0.8	1.3	0.8	1.3	0.8	1.3	V	



over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER	TEST CONDITIONS		V	T <sub>A</sub> = 25	°C	– 55°C TO	125°C	– 40°C TO	85°C	
PARAMETER			V <sub>cc</sub>	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
∆V <sub>T</sub> Hysteresis (V <sub>T+</sub> − V <sub>T−</sub> )			5 V	0.4		0.4		0.4		V
		I <sub>OH</sub> = –50 μΑ	4.5 V	4.4		4.4		4.4		
N/		I <sub>OH</sub> = −24 mA	4.5 V	3.94		3.7		3.8		
V <sub>OH</sub>	V <sub>1</sub> = V <sub>T+</sub>	I <sub>OH</sub> = −50 mA <sup>(1)</sup>	5.5 V			3.85				V
		I <sub>OH</sub> = −75 mA <sup>(1)</sup>	5.5 V					3.85		
	V <sub>I</sub> = V <sub>T-</sub>	$I_{OL} = 50$ $\mu A^{(1)}$	4.5 V		0.1		0.1		0.1	
		I <sub>OL</sub> = 24 mA <sup>(1)</sup>	4.5 V		0.36		0.5		0.44	V
V <sub>OL</sub>		I <sub>OL</sub> = 50 mA <sup>(1)</sup>	5.5 V				1.65			v
		I <sub>OL</sub> = 75 mA <sup>(1)</sup>	5.5 V						1.65	
l <sub>l</sub>	V <sub>I</sub> = V <sub>CC</sub> o	or GND	5.5 V		±0.1		±1		±1	μA
I <sub>CC</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND,	I <sub>O</sub> = 0	5.5 V		4		80		40	μA
ΔI <sub>CC</sub> <sup>(2)</sup>	V <sub>I</sub> = V <sub>CC</sub> -	- 2.1 V	4.5 V to 5.5 V		2.4		3		2.8	mA
Ci					10		10		10	pF

(1) Test one output at a time, not exceeding 1-second duration. Measurement is made by forcing indicated current and measuring voltage to minimize power dissipation. Test verifies a minimum 50-Ω transmission-line drive capability at 85°C and 75-Ω transmission-line drive capability at 125°C.

(2) Additional quiescent supply current per input pin, TTL inputs high, 1 unit load.

	Table 4-1. Act Input Load Table				
INPUT	UNIT LOAD				
A	0.21				

<sup>1.</sup> Unit load is  $\Delta I_{CC}$  limit specified in electrical characteristics table (e.g., 2.4 mA at 25°C).

#### 4.6 Switching Characteristics

over recommended operating free-air temperature range,  $V_{CC}$  = 5 V ± 0.5 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

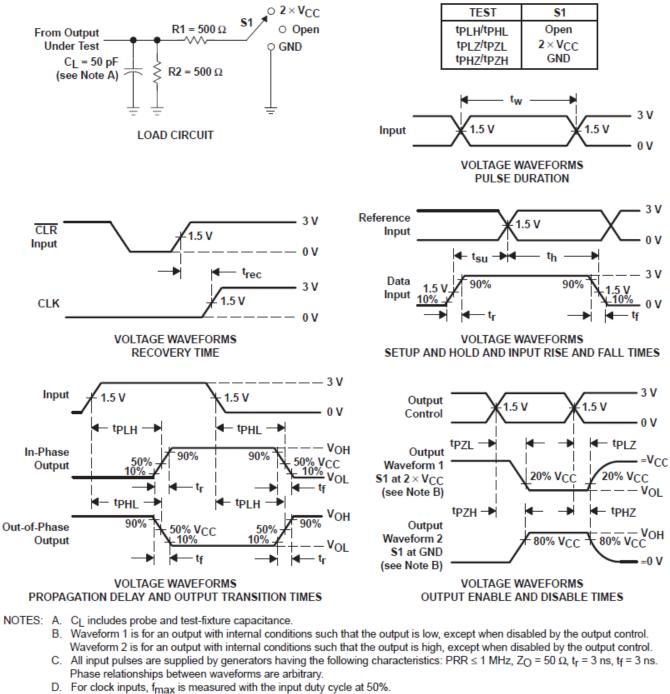
PARAMETER	FROM	TO (OUTPUT)	– 55°C to 125°C		– 40°C to 85°C		UNIT
	(INPUT)		MIN	MAX	MIN	MAX	UNIT
t <sub>PLH</sub>	A	Y	3.6	14.5	3.7	13.2	20
t <sub>PHL</sub>			2.4	9.5	2.4	8.6	ns

## 4.7 Operating Characteristics

 $V_{CC} = 5 V, T_A = 25^{\circ}C$ 

PARAMETEI	R	ТҮР	UNIT
C <sub>pd</sub>	Power dissipation capacitance	45	pF

### **5 Parameter Measurement Information**



- E. The outputs are measured one at a time, with one input transition per measurement.
- F. tp[H and tpH] are the same as t<sub>pd</sub>.
- G. tpzL and tpzH are the same as  $t_{en}$ .
- H. tpLz and tpHz are the same as  $t_{dis}$ .

#### Figure 5-1. Load Circuit and Voltage Waveforms



## 6 Detailed Description

#### 6.1 Overview

The CD74ACT14 contains six independent inverters. This device performs the Boolean function  $Y = \overline{A}$ .

Each circuit functions as an independent inverter, but because of the Schmitt action, the inverters have different input threshold levels for positive-going ( $V_{T+}$ ) and negative-going ( $V_{T-}$ ) signals.

## 6.2 Functional Block Diagram



Figure 6-1. Logic Diagram, Each Inverter (Positive Logic)

#### 6.3 Device Functional Modes

Table 6-1. Function	Table (Each Inverter)

INPUT	OUTPUT
A	Y
н	L
L	Н



## 7 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

#### 7.1 Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the Section 4.3 table.

Each V<sub>CC</sub> pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1  $\mu$ F is recommended. If there are multiple V<sub>CC</sub> pins, 0.01  $\mu$ F or 0.022  $\mu$ F is recommended for each power pin. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. A 0.1  $\mu$ F and 1  $\mu$ F are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

#### 7.2 Layout

#### 7.2.1 Layout Guidelines

When using multiple bit logic devices, inputs should not float. In many cases, functions or parts of functions of digital logic devices are unused. Some examples are when only two inputs of a triple-input AND gate are used, or when only 3 of the 4-buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states.

Specified in Example Layout are rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or  $V_{CC}$ , whichever makes more sense or is more convenient. It is acceptable to float outputs unless the part is a transceiver. If the transceiver has an output enable pin, it will disable the outputs section of the part when asserted. This will not disable the input section of the I/Os so they also cannot float when disabled.

#### 7.2.1.1 Layout Example

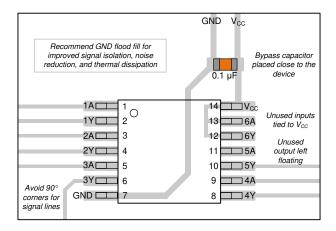


Figure 7-1. Layout Diagram

## 8 Device and Documentation Support

#### 8.1 Documentation Support (Analog)

#### 8.1.1 Related Documentation

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

PARTS	PARTS PRODUCT FOLDER		TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY							
CD74ACT14	Click here	Click here	Click here	Click here	Click here							

#### Table 8-1. Related Links

#### 8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 8.3 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 8.4 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

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#### 8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 8.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

#### **9 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	hanges from Revision B (August 2023) to Revision C (August 2024)	Page
•	Added body size to Package Information table	1
•	Updated R0JA values: D = 86 to 89.9, all values in °C/W	4
•	Updated packages from E and M to N and D	4

Changes from Revision A (November 2004) to Revision B (August 2023)	Page

 Added Package Information table, Pin Functions table, ESD Ratings table, Thermal Information table, Device Functional Modes, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section



## 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CD74ACT14E	ACTIVE	PDIP	Ν	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74ACT14E	Samples
CD74ACT14M96	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT14M	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW**: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## PACKAGE OPTION ADDENDUM

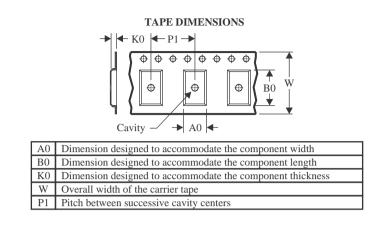
21-May-2024



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## TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74ACT14M96	SOIC	D	14	2500	330.0	12.4	3.75	3.75	1.15	8.0	12.0	Q1
CD74ACT14M96	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CD74ACT14M96	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1



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# PACKAGE MATERIALS INFORMATION

24-Oct-2024



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74ACT14M96	SOIC	D	14	2500	340.5	336.1	32.0
CD74ACT14M96	SOIC	D	14	2500	353.0	353.0	32.0
CD74ACT14M96	SOIC	D	14	2500	356.0	356.0	35.0

## TEXAS INSTRUMENTS

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## TUBE



## - B - Alignment groove width

\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
CD74ACT14E	N	PDIP	14	25	506	13.97	11230	4.32
CD74ACT14E	N	PDIP	14	25	506	13.97	11230	4.32

# **D0014A**



# **PACKAGE OUTLINE**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.



# D0014A

# **EXAMPLE BOARD LAYOUT**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# D0014A

# **EXAMPLE STENCIL DESIGN**

## SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



## N (R-PDIP-T\*\*)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- $\triangle$  The 20 pin end lead shoulder width is a vendor option, either half or full width.



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